Search Notes



Application/Control No.	Applicant(s)/Patent und Reexamination
40/040 004	AAUGU CD CT AI

10/840,224 Examiner

Quynh H. Nguyen

Applicant(s)/Patent under
Reexamination
MUELLER ET AL.
Art Unit
2614

SEARCHED				
Class	Subclass	Date	Examiner	
379	373.01 373.02 373.03 373.04 373.05	6/20/06	QN	
above	updated	11/28/2006	QN	
above	updated	5/16/2007	QN	
above	updated	10/30/2007	QN	
		4.700	-	
	1	L	L	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
searched: East,USPGPub, USPAT	6/20/2006	QN	
inventor searched through PALM database	6/20/2006	QN	